## Soft X-ray Absorption and Photoemission Studies of Ferromagnetic Mn-Implanted 3C-SiC

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We have performed x-ray photoemission spectroscopy (XPS), x-ray absorption spectroscopy (XAS), and resonant photoemission spectroscopy (RPES) measurements of Mn-implanted 3C-SiC  $(3C\text{-SiC:}Mn)$  and carbon-incorporated  $Mn_5Si_2$  ( $Mn_5Si_2:C$ ). The Mn 2p core-level XPS and XAS spectra of 3C-SiC:Mn and  $Mn_5Si_2:C$  were similar to each other and showed gintermediateh behaviors between the localized and itinerant Mn 3d states. The intensity at the Fermi level was found to be suppressed in 3C-SiC:Mn compared with Mn5Si2:C. These observations are consistent with the formation of  $Mn_5Si_2:C$  clusters in the 3C-SiC host, as observed in a recent transmission electron microscopy study.

KEYWORDS: diluted magnetic semiconductor, SiC, silicide, electronic structure, photoemission spectroscopy, x-ray absorption spectroscopy

In recent years, there has been growing interest in the possibility of using electron spins in electronic devices for the transfer, processing, and storage of information. In such prospects for the realization of spintronic devices, diluted magnetic semiconductors (DMSs) are key materials and remarkable development has been achieved after the discovery of the relatively high Curie temperature  $(T_C \sim 110 \text{ K})$  in  $Ga_{1-x}Mn_xAs$ .[\[1](#page-3-0)] Inspired by the theoretical predictions toward DMSs with higher  $T_{\rm C}$ 's, [\[2,](#page-3-1) [3,](#page-3-2) [4](#page-3-3)] various experimental studies on wide-gap DMSs, especially ZnO and GaN, have been performed and many wide-gap DMSs have been reported to show ferromagnetism at room temperature.[\[5,](#page-3-4) [6,](#page-3-5) [7](#page-3-6), [8\]](#page-3-7) However, only few experimental studies on silicon carbide (SiC)-based DMS have been reported [\[9,](#page-3-8) [10](#page-3-9)] in spite of the high potential of SiC for high-power devices because of its wide band gap, high thermal conductivity, high hardness, and chemical inertness.

Recently, Takano  $et \ al.[11]$  $et \ al.[11]$  have reported ferromagnetism in Mn-implanted 3C-SiC (3C-SiC:Mn) and a  $T<sub>C</sub>$ of 245 K has been observed. In their report, high resolution transmission electron microscopy (HRTEM) and selected-area diffraction (SAD) measurements have revealed that cluster precipitations occurred in 3C-SiC:Mn and that electron diffraction from the cluster region showed superposed patterns of  $Mn_5Si_2$  and 3C-SiC. The Mn content was estimated to be 20 % in the cluster region and below  $1\%$  in the 3C-SiC host region from energy dispersive x-ray measurements. Since  $Mn_5Si_2$  is known as a paramagnetic metal,[\[12\]](#page-3-11) the ferromagnetism of the 3C-SiC:Mn sample cannot be explained simply by the existence of  $Mn_5Si_2$ . On the other hand, a  $Mn_5Si_2$ -derived ferromagnetic material generated by thermal reaction between Mn and  $4H$ -SiC has been recently reported, [\[13\]](#page-3-12) and the  $T_{\rm C}$  of 300 K and the ferromagnetic hysteresis have been observed. HRTEM and SAD analysis were also performed on this material and the diffraction from the reacted region showed a clear pattern of  $Mn_5Si_2$ . Because the ferromagnetic hysteresis disappeared when the Mn5Si2-derived region was removed by chemical etching, it was proposed that carbon incorporation into the paramagnetic  $Mn_5Si_2$  caused the ferromagnetism. [\[14\]](#page-3-13) The incorporation of carbon atoms was confirmed by secondary ion mass spectrometry and also by C 1s core-level photoemission. It has remained unclear, however, whether the ferromagnetism of 3C-SiC:Mn comes from dilute Mn atoms in the SiC host (SiC:Mn DMS) or the clusters of carbon-incorporated  $Mn_5Si_2(Mn_5Si_2:C)$ . The characterization of the electronic structure using high energy spectroscopic methods such as photoemission spectroscopy and x-ray absorption spectroscopy will bring us more direct information.

In this study, we present the results of x-ray photoemission spectroscopy (XPS), x-ray absorption spectroscopy (XAS), and resonant photoemission spectroscopy (RPES) measurement of 3C-SiC:Mn. For comparison, those of  $Mn_5Si_2:C$  are also presented. The electronic structure of Mn and a possible origin of the ferromagnetism in 3C-SiC:Mn are discussed.

3C-SiC:Mn was fabricated by Mn-implantation into a  $3C-SiC$  (001) wafer with a 5  $\mu$ m homoepitaxial layer. The epitaxial layer showed  $n$ -type conduction with the carrier density of  $1 \times 10^{16}$  cm<sup>-3</sup>. The Mn implantation energy of 350 keV was employed and the dose was  $1\times10^{16}$ cm<sup>−</sup><sup>2</sup> . During the implantation, the wafer was maintained at 800 ◦C to prevent amorphization. The implanted wafer was annealed at 1650 ◦C for 20 min in an Ar atmosphere. Details of the sample preparation and characterization were described elsewhere.[\[11\]](#page-3-10)  $Mn_5Si_2:C$ was fabricated by depositing Mn metal on a 4H-SiC homoepitaxial wafer followed by annealing. As the first step, the SiC wafer was thermally cleaned at 1000 ◦C for 10 min in a high vacuum chamber ( $\sim 1.3 \times 10^{-6}$  Pa during cleaning) to remove thin oxide layer at the surface. After the cleaning, Mn with a thickness of ∼50 nm was deposited on the surface using a Knudsen cell in an ultrahigh vacuum chamber at a substrate temperature of 300 ◦C. As the last step, annealing was performed at 1000 ◦C for 3 min. Details of the sample preparation and characterization were described in elsewhere.[\[13](#page-3-12)]

XPS measurements were performed using a Gammadata Scienta SES-100 hemispherical analyzer and a Mg- $K\alpha$  source ( $h\nu = 1253.6$  eV). The XAS and RPES measurements were performed at BL23SU of SPring-8 using photons of  $h\nu = 630 - 660$  eV. Photoelectrons were collected by a Gammadata Scienta SES-2002 hemispherical analyzer. All the spectra were taken at room temperature. The total resolution of the spectrometer including thermal broadening was ∼800 meV for XPS and ∼200 meV for RPES, respectively. The monochromator resolution was  $E/\Delta E > 10,000$ . The absorption spectra were measured by the total electron yield method. The base pressure was below  $3\times10^{-8}$  Pa. Prior to the measurements,  $Ar^+$ -ion sputter etching was performed for surface cleaning. The Ar pressure was  $1\times10^{-5}$  Pa and the incident angle of the  $Ar^+$ -ion beam was fixed at and 45 $\degree$ from the surface normal. The acceleration voltage was chosen as 1.5 kV for XPS and 3 kV for XAS and RPES.

Figure 1 shows the Mn 2p core-level XPS spectra of 3C- $SiC:$ Mn and  $Mn_5Si_2:C$ . For comparison, the spectrum of Mn metal and that of an oxidized surface of  $Mn_5Si_2:C$ which was taken before sputtering are also shown. Here, the spectra have been normalized to the maximum intensity of the Mn  $2p_{3/2}$  peak. The two-peak structure due to the Mn  $2p_{3/2}$  and  $2p_{1/2}$  spin-orbit splitting is seen in every spectrum. One can see that the spectrum of 3C-SiC:Mn is similar to that of  $Mn_5Si_2:C$  and also that of Mn metal. The peak positions of the Mn  $2p_{3/2}$  peaks of 3C- $SiC:Mn$ ,  $Mn_5Si_2:C$ , and Mn metal are almost the same at 639 eV, but differ from that (642 eV) of the oxidized surface. Not only the energy positions but also the line shapes are similar between  $3C$ -SiC:Mn,  $Mn_5Si_2:C$ , and Mn metal and obviously differ from those of the oxidized surface. The asymmetric tails appearing on the higher binding energy  $(E_B)$  side of the peaks are well known as a characteristic feature of metallic systems, caused by the screening of the core hole by conduction electrons.[\[15\]](#page-3-14) On the contrary, the peak of the oxidized surface does not show an asymmetric line shape and is relatively broad. If the Mn ions doped in 3C-SiC substitute for the Si and/or C sites, namely, the Mn atoms are tetrahedrally coordinated by C and/or Si atoms, the spectrum would show a



FIG. 1: (Color online) Mn 2p core-level spectra of 3C-SiC:Mn and  $Mn_5Si_2:C$ . Dashed lines indicates the position of the  $2p_{3/2}$ peak. For comparison, the spectra of Mn metal and Mn5Si2:C taken before sputtering (oxidized surface) are shown.

spectral line shape similar to those of  $\text{Zn}_{1-x}\text{Mn}_x\text{O},[16]$  $\text{Zn}_{1-x}\text{Mn}_x\text{O},[16]$  $\text{Zn}_{1-x}\text{Mn}_x\text{O},[16]$  $Ga_{1-x}Mn_xAs$ ,[\[17\]](#page-3-16) and  $Ga_{1-x}Mn_xN$ .[\[18](#page-3-17)] This indicates that both Mn atoms in  $3C$ -SiC:Mn and in  $Mn_5Si_2:C$  are not tetrahedrally coordinated by C and/or Si atoms and have local electronic structures which are relatively similar to that of Mn metal. We note that there is a slight broadening of the asymmetric tails of the Mn 2p peaks for  $3C$ -SiC:Mn and  $Mn_5Si_2:C$  compared to that for Mn metal. Similar broadening was observed in the case of the Mn:Ge system.[\[19](#page-3-18)] In this reference, hybridization between the Mn 3d orbitals and Ge valence orbitals, namely, covalency was proposed as the origin of the broadening of the Mn 2p core-level photoemission spectrum compared to that of Mn metal. Therefore, it is likely that Mn - Si or Mn - C hybridization causes the slight peak broadening observed in the present case.

Figure 2 shows the Mn 2p XAS spectra of 3C-SiC:Mn and  $Mn_5Si_2:C$ , together with that of Mn metal and that of oxidized surface of  $Mn_5Si_2:C$  taken before sputtering. Here, the spectra have been aligned at the main peak, and the intensities of these spectra have been normalized to the maximum intensity of the main peak. The fine structures observed for the spectrum of the oxidized surface show multiplet structures characteristic of the localized 3d states of the  $Mn^{2+}$  ion.[\[20](#page-3-19)] As in the case of the XPS result, the XAS spectra of 3C-SiC:Mn and  $Mn_5Si_2:C$  have almost the same line shapes and are similar to that of Mn metal, indicating that the electronic structures of Mn in  $3C$ -SiC:Mn and  $Mn_5Si_2:C$  are rather similar to that of Mn metal. The spectra, however, show weak peaks and shoulders indicated by dashed vertical lines. These structures may represent weakly localized states of the  $Mn^{2+}$  ion. In the system of Mn:Ge,[\[19\]](#page-3-18) too, in addition to the globally metal-like line shape of Mn 2p



FIG. 2: (Color online) Mn 2p XAS spectra of 3C-SiC:Mn and  $Mn_5Si_2:C$ . For comparison, the spectra of Mn metal and  $Mn_5Si_2:C$  taken before sputtering (oxidized surface) are shown. Dashed vertical lines indicate the peak or shoulder positions.

XAS, weak multiplet structures were observed and were considered as a result of hybridization between Mn and Ge. Carbone et al.[\[21\]](#page-3-20) also suggested that covalency in MnSi, which is a helimagnetic metal, could be the origin of the multiplet structures superposed on the metallic feature of the Mn 2p XAS spectrum. Therefore, it is likely that Mn 3d electrons in 3C-SiC:Mn and  $Mn_5Si_2:C$ are gintermediateh between the localized and itinerant limits. We note that another possible reason for the observed intermediate behavior is the coexistence of metallic Mn and residual surface Mn oxides. In fact, a small amount of oxygen atoms were found in the O 1s core-level spectra (13% and 19% of the total number of atoms for  $3C-SiC:$ Mn and Mn<sub>5</sub>Si<sub>2</sub>:C, estimated from the intensities of the Mn 2p, Si 2p, C 1s and O 1s core-level spectra). However, since the Mn 2p XPS spectra of 3C-SiC:Mn and Mn5Si2:C were quite different from that of the oxidized surface, we believe that most of the Mn atoms in 3C- $SiC:$ Mn and  $Mn_5Si_2:C$  were not oxidized. Thus, one can conclude that the electronic structure of Mn in 3C-SiC is similar to that in  $Mn_5Si_2:C$ , consistent with the result of the TEM study which has demonstrated the existence of  $Mn_5Si_2$ -derived clusters in 3C-SiC.[\[11\]](#page-3-10)

We have also studied the valence-band electronic states by Mn 2p-3d RPES measurements. RPES is a powerful tool to investigate the electronic structure of doped Mn ions in DMS because the resonance enhancement of the Mn 3d partial density of states (PDOS) enables us to extract it from the valence band.[\[16,](#page-3-15) [18,](#page-3-17) [22\]](#page-3-21) Figure 3 shows the Mn 2p-3d RPES spectra of 3C-SiC:Mn and  $Mn_5Si_2:C.$  The RPES spectra of 3C-SiC:Mn shown in panel (a) exhibit only weak resonant enhancement because of the low Mn content in  $3C$ -SiC (below 1 at.%) Mn estimated from the intensities of the Si  $2p$ , C  $1s$ , and Mn 2p core-level XPS spectra). Nevertheless, a dif-

ference spectrum has been clearly obtained by subtracting the off-resonance spectrum A from the on-resonance spectrum  $B$  as shown at the bottom of panel (a). The RPES spectra of  $Mn_5Si_2:C$  shown in panel (b) clearly exhibit much stronger resonance enhancement as well as the Fermi edge, but are dominated by the Mn  $L_3VV$  Auger peaks, move toward higher  $E_B$  with increasing photon energy because Auger electrons have constant kinetic energies. The strong Auger signal is a typical feature of a metallic material. The appreciable resonance enhancement of the Fermi edge in panel (b) indicates that the conduction electrons have sizable amount of Mn 3d character, whereas

we could not observe detectable intensity at  $E_F$  of  $3C-SiC:Mn$  as shown in panel (a). In general, the electronic structure of a metal cluster including the intensity at  $E_F$  is size-dependent. It is considered that finite size effects become observable for metal particles typically smaller than 10 nm.[\[23\]](#page-3-22) For example, theory of quantum size effect (Kubo effect) predicts the opening of a gap with decreasing cluster size.[\[23\]](#page-3-22) It has also been reported that final-state effects of photoemission process leads to the disappearance of the Fermi edges in small metal clusters.[\[24\]](#page-3-23) Therefore, the apparently different RPES spectra of  $3C$ -SiC:Mn and Mn<sub>5</sub>Si<sub>2</sub>:C are compatible with the similar Mn 2p XPS and XAS spec-



FIG. 3: (Color online) Comparison of the valence-band photoemission spectra of  $3C$ -SiC:Mn (a) and Mn<sub>5</sub>Si<sub>2</sub>:C (b) taken at various photon energies in the Mn 2p-3d core-excitation region. Black triangles represent the Mn  $L_3VV$  Auger signal. Insets in both panels show the corresponding Mn 2p XAS spectra. Arrows indicate the photon energy where the valence-band spectra were taken.

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The present results suggest that the local electronic structure of Mn in 3C-SiC is similar to that of Mn in  $Mn_5Si_2:C$  and different from the localized states which is expected for a transition-metal atom at the substitutional site of SiC. Furthermore, a blocking phenomenon and the blocking temperature of 215 K were observed from the field-cooling and zero-field-cooling magnetization measurements of the present 3C-SiC:Mn sample (not shown), suggesting that the ferromagnetic-like behavior of 3C-SiC:Mn comes from a group of clustered ferromagnets. Thus, it is considered that  $Mn_5Si_2:C$  clusters are responsible for the ferromagnetic properties of 3C-SiC:Mn. Since most of the implanted Mn atoms formed silicide clusters in the present study, the content of substitutional Mn in SiC may be small. A recent density functional calculation[\[25\]](#page-3-24) has pointed out that substitutional Mn atoms at the Si site prefer long-range ferromagnetic coupling in  $3C$ - and  $4H$ -SiC. Fabrication of SiC by molecular-beam epitaxy with high crystallinity have been reported[\[26\]](#page-3-25) and an incorporation of a substantial amount of Mn into substitutional sites using other techniques such as a low-temperature-molecular-beam epitaxy may be an interesting possible route to fabricate SiC-based ferromagnetic semiconductors.

We have performed Mn 2p XPS, XAS, and Mn 2p-3d RPES studies of 3C-SiC:Mn and  $Mn_5Si_2:C$ . The Mn  $2p$ XPS and XAS of 3C-SiC:Mn show gintermediateh feature, similar to  $Mn_5Si_2:C$ . In Mn  $2p-3d$  RPES, however, a clear Fermi edge of Mn 3d character has been observed for  $Mn_5Si_2:C$  while no Fermi edge was observed for 3C-SiC:Mn. Cluster size effects may explain the suppression of the intensity at  $E_F$  in 3C-SiC:Mn. These observations are consistent with the existence of  $Mn<sub>5</sub>Si<sub>2</sub>$ -derived clusters in 3C-SiC reported in the TEM study. It is possible that the  $Mn_5Si_2:C$  clusters are responsible for the ferromagnetism of 3C-SiC:Mn.

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